Se	arci	h Notes		

 Application/Control No.	Applicant(s)/Patent under Reexamination	
09/487,729	HAN, BAIK-HEE	
Examiner	Art Unit	
Paulos M. Natosel	2614	

SEARCHED			
Class	Subclass	Date	Examiner
updated	search	8/2/2005	PMN
>>	د <i>د</i>	8/4/2005	PMN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
348	732	8/2/2005	PMN
	L		
1	earch JSPGPUB	8/2/2005	PMN

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST, all data bases, including USPAT, USPGPUB, JPO, EPO, DERWENT, USOCR, IBM_TDB	8/2/2005	PMN
	8/4/2005	PMN
Consulted with J. Miller (spe 2614) and Victor Kostak, class 348	8/4/2005	PMN
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